

**Notice of References Cited**

Application/Control No.

10/623,569

Applicant(s)/Patent Under  
Reexamination  
MIYANO ET AL.

Examiner

Anish Desai

Art Unit

1771

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,166,799	12-2000	Kameyama et al.	349/185
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	E	US-			
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**NON-PATENT DOCUMENTS**

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